## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination LOUGHRAN ET AL. Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0223504	11-2004	Wybenga et al.	370/412
*	В	US-6,785,277	08-2004	Sundling et al.	370/392
*	С	US-2005/0078696	04-2005	Oner, Koray	370/419
*	D	US-2004/0202190	10-2004	Ricciulli, Livio	370/410
*	Ε	US-2004/0151170	08-2004	Gulati et al.	· 370/360
*	F	US-2003/0035375	02-2003	Freeman, Jay R.	370/238
*	G	US-2004/0246961	12-2004	Dai et al.	370/392
*	Н	US-2005/0025122	02-2005	Block et al.	370/351
*	ı	US-6,838,345	01-2005	Chang, Kent Kuohua	438/261
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				·	
	0					
	Р					
	Q					
	R					
	S.					
	Т					

## **NON-PATENT DOCUMENTS**

	NON-FAIENT DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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